

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination GONDEK, JAY S.	
			Examiner Beniyam Menberu	Art Unit 2625	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,421,142	07-2002	Lin et al.	358/1.9
*	B	US-6,765,586	07-2004	Yamazaki et al.	345/590
*	C	US-7,177,465	02-2007	Takahira, Masayuki	382/166
*	D	US-6,373,595	04-2002	Semba et al.	358/1.9
*	E	US-5,892,891	04-1999	Dalal et al.	358/1.9
*	F	US-7,064,864	06-2006	Takahashi et al.	358/1.9
*	G	US-2003/0072015	04-2003	Fujino, Makoto	358/1.9
*	H	US-2004/0096104	05-2004	Terekhov, Vladislav	382/167
*	I	US-2004/0136014	07-2004	Maltz, Martin S.	358/001.9
*	J	US-2004/0212814	10-2004	Ishigami, Koichiro	358/001.9
*	K	US-2005/0141848	06-2005	Deguchi et al.	386/001
*	L	US-2002/0149786	10-2002	Hudson et al.	358/1.9
*	M	US-2004/0100643	05-2004	Jones et al.	358/001.9

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.